



100V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	RDS(ON) Max	I _D T _C = +25°C
100V	$222m\Omega$ @ $V_{GS} = 10V$	8.0A
100 V	$270 \text{m}\Omega$ @ $V_{GS} = 4.5 \text{V}$	7.3A

Description and Applications

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

Load Switch

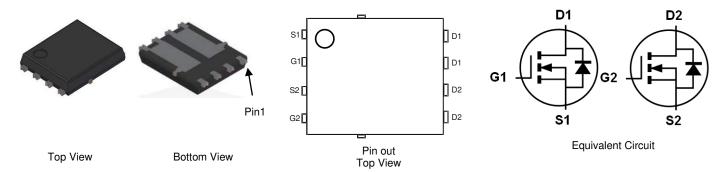
Features

- 100% Unclamped Inductive Switch (UIS) Test in Production
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Wettable Flank for Improved Optical Inspections
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative. https://www.diodes.com/quality/product-definitions/

Mechanical Data

- Case: PowerDI[®]5060-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.097 grams (Approximate)

PowerDI5060-8 (SWP) (Type R)



Ordering Information (Note 4)

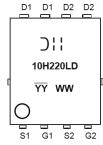
Part Number	Case	Packaging
DMN10H220LPDW-13	PowerDI5060-8 (SWP) (Type R)	2500 / Tape & Reel

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information

Notes:



☐ Manufacturer's Marking
☐ Marking Code
☐ Warking Code
☐ Warking
☐ Product Type Marking Code
☐ Warking
☐ Product Type Marking
☐ Warking



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		V _{DSS}	100	V
Gate-Source Voltage		V _{GSS}	±20	V
Continuous Drain Current (Note 6) Vgs = 10V	$T_C = +25$ °C $T_C = +70$ °C	lo	8.0 6.4	А
Maximum Body Diode Forward Current (Note 6)	•	ls	8.0	Α
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)		I _{DM}	32	Α
Pulsed Source Current (10μs Pulse, Duty Cycle = 1%)		Ism	32	А
Avalanche Current (Note 7)	L = 0.1mH	I _{AS}	4.7	А
Avalanche Energy (Note 7)	L = 0.1mH	Eas	1.1	mJ

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	P _D	2.2	W
Thermal Resistance, Junction to Ambient (Note 5)	R _{0JA}	57	°C/W
Thermal Resistance, Junction to Case (Note 6)	Rejc	5.8	G/ VV
Operating and Storage Temperature Range	TJ, TSTG	-55 to +150	°C

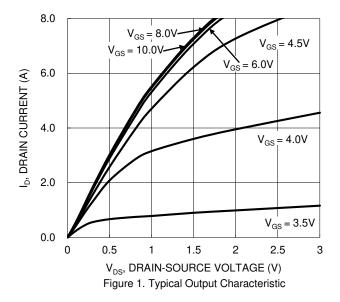
Electrical Characteristics (@TA = +25°C, unless otherwise specified.)

			•				
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BVDSS	100	_	_	V	$V_{GS} = 0V, I_{D} = 250\mu A$	
Zero Gate Voltage Drain Current	IDSS	_	_	1	μΑ	V _{DS} = 100V, V _{GS} = 0V	
Gate-Source Leakage	Igss	_	_	100	nA	V _G S = ±20V, V _D S = 0V	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(TH)}	1	_	2.5	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	
Static Drain-Source On-Resistance	Decrees	_	168	222	mΩ	V _{GS} = 10V, I _D = 2A	
Static Dialii-Source Off-Nesistance	RDS(ON)	_	208	270	mΩ	V _{GS} = 4.5V, I _D = 1A	
Diode Forward Voltage	V _{SD}	_	0.8	1.3	V	V _G S = 0V, I _S = 2A	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	Ciss	_	384	_		V 05V & 4MIL	
Output Capacitance	Coss	_	23	_	pF	$V_{DS} = 25V$, $f = 1MHz$, $V_{GS} = 0V$	
Reverse Transfer Capacitance	Crss	_	17	_		VGS = UV	
Gate Resistance	Rg	_	2.4	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (VGS = 4.5V)	Qg	_	3.7	_			
Total Gate Charge (VGS = 10V)	Qg	_	6.7	_	nC V _{DD} = 50V, I _D = 1.6A		
Gate-Source Charge	Qgs	_	1.3	_	110	$V_{DD} = 50V, I_D = 1.6A$	
Gate-Drain Charge	Q_{gd}	_	2	_			
Turn-On Delay Time	tD(ON)	_	6.2	_			
Turn-On Rise Time	tr	_	8.7	_	$V_{DD} = 50V, V_{GS} = 4.5V,$		
Turn-Off Delay Time	t _{D(OFF)}	_	7.4	_	ns	$R_G = 6.8\Omega$, $I_D = 1.0A$	
Turn-Off Fall Time	t _F	_	4.2	_			
Body Diode Reverse Recovery Time	trr	_	20	_	ns	I- 4 4 A 41/44 4 4 0 0 A / 1 -	
Body Diode Reverse Recovery Charge	Qrr	_	11	_	nC	$Is = 1.1A$, $dI/dt = 100A/\mu s$	

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate.

- 6. Thermal resistance from junction to soldering point (on the exposed drain pad).
- 7. I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep $T_{J} = +25^{\circ}C$.
- 8. Short duration pulse test used to minimize self-heating effect.
- 9. Guaranteed by design. Not subject to product testing.





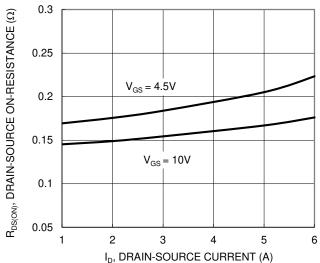


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

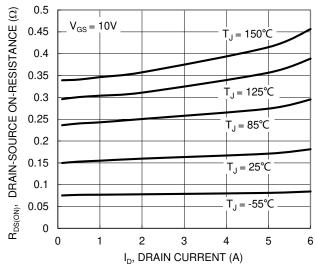
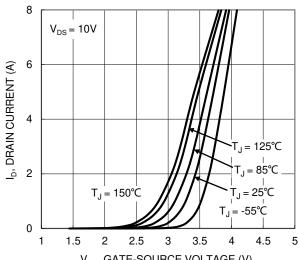


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature



V_{GS}, GATE-SOURCE VOLTAGE (V) Figure 2. Typical Transfer Characteristic

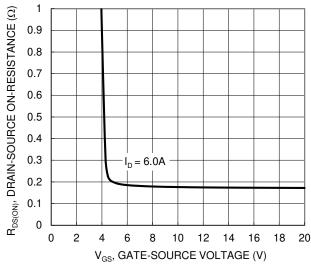


Figure 4. Typical Transfer Characteristic

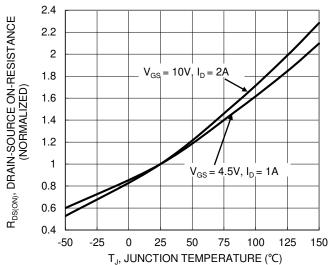
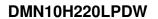


Figure 6. On-Resistance Variation with Junction Temperature





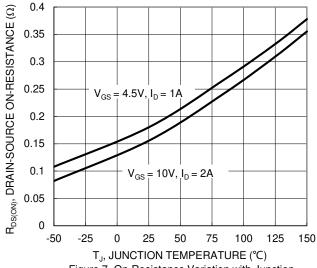


Figure 7. On-Resistance Variation with Junction Temperature

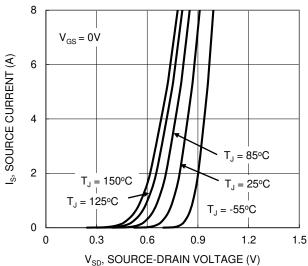
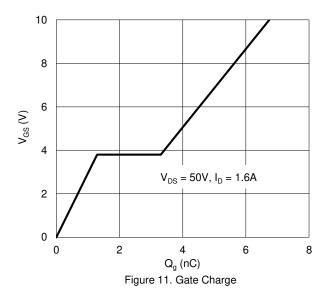
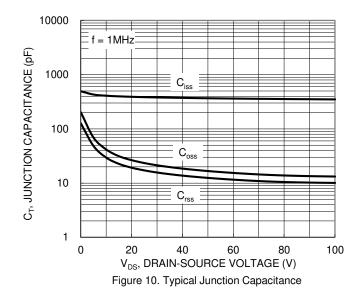


Figure 9. Diode Forward Voltage vs. Current



3 2.8 $V_{\text{GS(TH)}},$ GATE THRESHOLD VOLTAGE (V) 2.6 2.4 2.2 $I_D = 1mA$ 2 1.8 1.6 1.4 $I_{D} = 250 \mu A$ 1.2 1 0.8 0.6 0.4 -50 -25 0 25 50 75 100 125 150 T_J, JUNCTION TEMPERATURE (°C)

Figure 8. Gate Threshold Variation vs. Junction Temperature



100 1μs 🗐 R_{DS(ON)} Limited $P_W = 10\mu s$ 10 ID, DRAIN CURRENT (A) $= 100 \mu s$ 1 $T_{J(Max)} = 150^{\circ}C$ 0.1 T_C = 25°C Single Pulse DUT on Infinite Heatsink $V_{GS} = 10V$ 0.01 0.1 10 V_{DS}, DRAIN-SOURCE VOLTAGE (V) Figure 12. SOA, Safe Operation Area



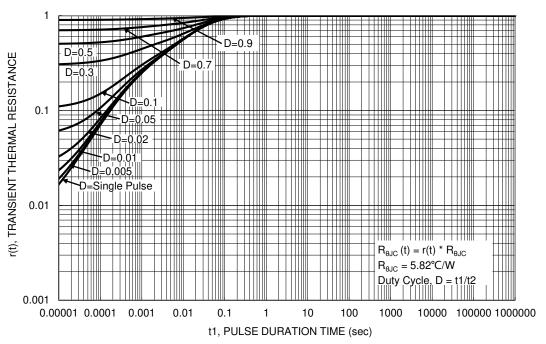


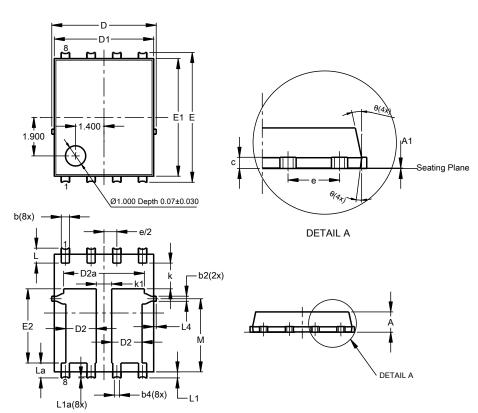
Figure 13. Transient Thermal Resistance



Package Outline Dimensions

 $Please see \ http://www.diodes.com/package-outlines.html \ for \ the \ latest \ version.$

PowerDI5060-8 (SWP) (Type R)

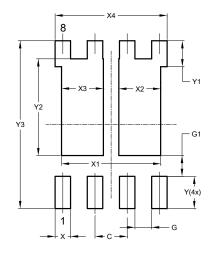


Pov	verDI50	060-8 (5	SWP)
		oe R)	, ,
Dim	Min	Max	Тур
Α	0.90	1.10	1.00
A 1	0	0.05	
b	0.30	0.50	0.41
b2	0.20	0.35	0.25
b4	0).25REI	F
С	0.230	0.330	0.277
D	5	.15 BS	C
D1	4.70	5.10	4.90
D2	1.40	1.60	1.50
D2a	3.78	4.18	3.98
Е	6	.40 BS	
E1	5.60	6.00	5.80
E2	3.46	3.86	3.66
е		.27BS0	
k	1.05		
k1	0.56		
L	0.635	0.835	0.735
La	0.635	0.835	0.735
L1	0.200	0.400	0.300
L1a	0.	.050RE	
L4	0.025	0.225	0.125
М	3.205	4.005	3.605
θ	10°	12°	11°
θ1	6°	8°	7°
All I	Dimens	sions ir	mm r

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

PowerDI5060-8 (SWP) (Type R)



(in mm)	Dimensions
1 070	Dilliensions
U 1.270	С
G 0.660	G
G1 0.820	G1
X 0.610	X
X1 3.910	X1
X2 1.650	X2
X3 1.650	Х3
X4 4.420	X4
Y 1.270	Y
Y1 1.020	Y1
Y2 3.810	Y2
Y3 6.610	Y3



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